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#### Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

#### Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

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Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.333GHz
Co-Processors/DSP	Signal Processing; SPE, Security; SEC
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	-40°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc8548ecvtaujd

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

# 2 Electrical Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the device. This device is currently targeted to these specifications. Some of these specifications are independent of the I/O cell, but are included for a more complete reference. These are not purely I/O buffer design specifications.

## 2.1 **Overall DC Electrical Characteristics**

This section covers the ratings, conditions, and other characteristics.

## 2.1.1 Absolute Maximum Ratings

The following table provides the absolute maximum ratings.

Table 1. Absolute	Maximum	Ratings	1
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Characteristic		Symbol	Max Value	Unit	Notes
Core supply vo	bltage	V <sub>DD</sub>	-0.3 to 1.21	V	—
PLL supply vol	tage	AV <sub>DD</sub>	-0.3 to 1.21	V	—
Core power su	pply for SerDes transceivers	SV <sub>DD</sub>	-0.3 to 1.21	V	—
Pad power sup	oply for SerDes transceivers	XV <sub>DD</sub>	-0.3 to 1.21	V	—
DDR and DDR	2 DRAM I/O voltage	GV <sub>DD</sub>	-0.3 to 2.75 -0.3 to 1.98	V	2
Three-speed E	thernet I/O voltage	LV <sub>DD</sub> (for eTSEC1 and eTSEC2)	-0.3 to 3.63 -0.3 to 2.75	V	
		TV <sub>DD</sub> (for eTSEC3 and eTSEC4)	-0.3 to 3.63 -0.3 to 2.75		3
PCI/PCI-X, DU I <sup>2</sup> C, Ethernet N	IART, system control and power management, /III management, and JTAG I/O voltage	m control and power management, OV <sub>DD</sub> -0.3 to 3.63 ment, and JTAG I/O voltage		V	_
Local bus I/O	/oltage	BV <sub>DD</sub> -0.3 to 3.63 V -0.3 to 2.75		V	—
Input voltage	DDR/DDR2 DRAM signals	MV <sub>IN</sub>	–0.3 to (GV <sub>DD</sub> + 0.3)	V	4
	DDR/DDR2 DRAM reference	MV <sub>REF</sub>	-0.3 to (GV <sub>DD</sub> /2 + 0.3)	V	—
	Three-speed Ethernet I/O signals	LV <sub>IN</sub> TV <sub>IN</sub>	-0.3 to (LV <sub>DD</sub> + 0.3) -0.3 to (TV <sub>DD</sub> + 0.3)	V	4
	Local bus signals	BV <sub>IN</sub>	-0.3 to (BV <sub>DD</sub> + 0.3)	_	—
	DUART, SYSCLK, system control and power management, I <sup>2</sup> C, Ethernet MII management, and JTAG signals	OV <sub>IN</sub>	-0.3 to (OV <sub>DD</sub> + 0.3)	V	4
	PCI/PCI-X	OV <sub>IN</sub>	-0.3 to (OV <sub>DD</sub> + 0.3)	V	4

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Characteristic	Symbol	Max Value	Unit	Notes
Storage temperature range	T <sub>STG</sub>	-55 to 150	°C	

#### Table 1. Absolute Maximum Ratings <sup>1</sup> (continued)

Notes:

- 1. Functional and tested operating conditions are given in Table 2. Absolute maximum ratings are stress ratings only, and functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.
- 2. The -0.3 to 2.75 V range is for DDR and -0.3 to 1.98 V range is for DDR2.
- 3. The 3.63 V maximum is only supported when the port is configured in GMII, MII, RMII, or TBI modes; otherwise the 2.75 V maximum applies. See Section 8.2, "FIFO, GMII, MII, TBI, RGMII, RMII, and RTBI AC Timing Specifications," for details on the recommended operating conditions per protocol.
- 4. (M,L,O)V<sub>IN</sub> may overshoot/undershoot to a voltage and for a maximum duration as shown in Figure 2.

### 2.1.2 Recommended Operating Conditions

The following table provides the recommended operating conditions for this device. Note that the values in this table are the recommended and tested operating conditions. Proper device operation outside these conditions is not guaranteed.

	Characteristic	Symbol	Recommended Value	Unit	Notes
Core supply voltag	e	V <sub>DD</sub>	1.1 V ± 55 mV	V	
PLL supply voltage		AV <sub>DD</sub>	1.1 V ± 55 mV	V	1
Core power supply	for SerDes transceivers	SV <sub>DD</sub>	1.1 V ± 55 mV	V	
Pad power supply	for SerDes transceivers	XV <sub>DD</sub>	1.1 V ± 55 mV	V	
DDR and DDR2 DI	RAM I/O voltage	GV <sub>DD</sub>	2.5 V ± 125 mV 1.8 V ± 90 mV	V	—
Three-speed Ethernet I/O voltage		LV <sub>DD</sub>	3.3 V ± 165 mV 2.5 V ± 125 mV	V	4
		TV <sub>DD</sub>	3.3 V ± 165 mV 2.5 V ± 125 mV	_	4
PCI/PCI-X, DUART Ethernet MII mana	I-X, DUART, system control and power management, I <sup>2</sup> C, OV <sub>DD</sub> at MII management, and JTAG I/O voltage		3.3 V ± 165 mV	V	3
Local bus I/O volta	ge	$\begin{array}{c c c c c c c c c c c c c c c c c c c $		V	—
Input voltage	DDR and DDR2 DRAM signals	MV <sub>IN</sub>	GND to GV <sub>DD</sub>	V	2
	DDR and DDR2 DRAM reference	MV <sub>REF</sub>	GND to GV <sub>DD</sub> /2	V	2
	Three-speed Ethernet signals	LV <sub>IN</sub> TV <sub>IN</sub>	GND to LV <sub>DD</sub> GND to TV <sub>DD</sub>	V	4
	Local bus signals	BV <sub>IN</sub>	GND to BV <sub>DD</sub>	V	
	PCI, DUART, SYSCLK, system control and power management, I <sup>2</sup> C, Ethernet MII management, and JTAG signals	OV <sub>IN</sub>	GND to OV <sub>DD</sub>	V	3

**Table 2. Recommended Operating Conditions** 

Characteristic	Symbol	Recommended Value	Unit	Notes
Junction temperature range	Tj	0 to 105	°C	_

#### Table 2. Recommended Operating Conditions (continued)

#### Notes:

1. This voltage is the input to the filter discussed in Section 22.2, "PLL Power Supply Filtering," and not necessarily the voltage at the AV<sub>DD</sub> pin, which may be reduced from V<sub>DD</sub> by the filter.

- Caution: MV<sub>IN</sub> must not exceed GV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 3. Caution: OV<sub>IN</sub> must not exceed OV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 4. Caution: L/TV<sub>IN</sub> must not exceed L/TV<sub>DD</sub> by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.

The following figure shows the undershoot and overshoot voltages at the interfaces of this device.



The core voltage must always be provided at nominal 1.1 V. Voltage to the processor interface I/Os are provided through separate sets of supply pins and must be provided at the voltages shown in Table 2. The input voltage threshold scales with respect to the associated I/O supply voltage.  $OV_{DD}$  and  $LV_{DD}$  based receivers are simple CMOS I/O circuits and satisfy appropriate LVCMOS type specifications. The DDR SDRAM interface uses a single-ended differential receiver referenced the externally supplied  $MV_{REF}$  signal (nominally set to  $GV_{DD}/2$ ) as is appropriate for the SSTL2 electrical signaling standard.

### NOTE

From a system standpoint, if any of the I/O power supplies ramp prior to the  $V_{DD}$  core supply, the I/Os associated with that I/O supply may drive a logic one or zero during power-up, and extra current may be drawn by the device.

Table 13 provides the recommended operating conditions for the DDR SDRAM controller when  $GV_{DD}(typ) = 2.5 \text{ V}.$ 

Parameter/Condition	Symbol	Min	Max	Unit	Notes
I/O supply voltage	GV <sub>DD</sub>	2.375	2.625	V	1
I/O reference voltage	MV <sub>REF</sub>	$0.49 \times GV_{DD}$	$0.51 \times GV_{DD}$	V	2
I/O termination voltage	V <sub>TT</sub>	MV <sub>REF</sub> – 0.04	MV <sub>REF</sub> + 0.04	V	3
Input high voltage	V <sub>IH</sub>	MV <sub>REF</sub> + 0.15	GV <sub>DD</sub> + 0.3	V	—
Input low voltage	V <sub>IL</sub>	-0.3	MV <sub>REF</sub> – 0.15	V	—
Output leakage current	I <sub>OZ</sub>	-50	50	μA	4
Output high current (V <sub>OUT</sub> = 1.95 V)	I <sub>OH</sub>	-16.2	—	mA	—
Output low current ( $V_{OUT} = 0.35 V$ )	I <sub>OL</sub>	16.2	—	mA	—

Table 13	DDR SDRAM	DC Electrical	Characteristics	for GV	(tvn) = 2	25 V
Table 15.	DDIX SDIXAM		Gilaracteristics		(()) – 4	1.J V

#### Notes:

1.  ${\rm GV}_{\rm DD}$  is expected to be within 50 mV of the DRAM  ${\rm V}_{\rm DD}$  at all times.

2. MV<sub>REF</sub> is expected to be equal to 0.5 × GV<sub>DD</sub>, and to track GV<sub>DD</sub> DC variations as measured at the receiver. Peak-to-peak noise on MV<sub>REF</sub> may not exceed ±2% of the DC value.

3. V<sub>TT</sub> is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV<sub>REF</sub>. This rail must track variations in the DC level of MV<sub>REF</sub>.

4. Output leakage is measured with all outputs disabled, 0 V  $\leq$  V<sub>OUT</sub>  $\leq$  GV<sub>DD</sub>.

Table 14 provides the DDR I/O capacitance when  $GV_{DD}(typ) = 2.5$  V.

#### Table 14. DDR SDRAM Capacitance for GV<sub>DD</sub>(typ) = 2.5 V

Parameter/Condition	Symbol	Min	Мах	Unit	Notes
Input/output capacitance: DQ, DQS	C <sub>IO</sub>	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C <sub>DIO</sub>	—	0.5	pF	1

#### Note:

1. This parameter is sampled.  $GV_{DD} = 2.5 \text{ V} \pm 0.125 \text{ V}$ , f = 1 MHz, T<sub>A</sub> = 25°C,  $V_{OUT} = GV_{DD}/2$ ,  $V_{OUT}$  (peak-to-peak) = 0.2 V.

This table provides the current draw characteristics for MV<sub>REF</sub>.

#### Table 15. Current Draw Characteristics for MV<sub>REF</sub>

Parameter/Condition	Symbol	Min	Мах	Unit	Notes
Current draw for MV <sub>REF</sub>	I <sub>MVREF</sub>		500	μA	1

#### Note:

1. The voltage regulator for  $MV_{REF}$  must be able to supply up to 500  $\mu$ A current.

Figure 14 shows the TBI transmit AC timing diagram.



Figure 14. TBI Transmit AC Timing Diagram

### 8.2.4.2 TBI Receive AC Timing Specifications

This table provides the TBI receive AC timing specifications.

able 31. TE	I Receive	<b>AC</b> Timing	Specifications
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Parameter/Condition	Symbol <sup>1</sup>	Min	Тур	Max	Unit
TSEC <i>n</i> _RX_CLK[0:1] clock period	t <sub>TRX</sub>	—	16.0	—	ns
TSEC <i>n</i> _RX_CLK[0:1] skew	t <sub>SKTRX</sub>	7.5	—	8.5	ns
TSECn_RX_CLK[0:1] duty cycle	t <sub>TRXH</sub> /t <sub>TRX</sub>	40	—	60	%
RCG[9:0] setup time to rising TSEC <i>n</i> _RX_CLK	t <sub>TRDVKH</sub>	2.5	—	—	ns
RCG[9:0] hold time to rising TSEC <i>n</i> _RX_CLK	t <sub>TRDXKH</sub>	1.5	—	—	ns
TSEC <i>n</i> _RX_CLK[0:1] clock rise time (20%–80%)	t <sub>TRXR</sub> <sup>2</sup>	0.7	—	2.4	ns
TSEC <i>n</i> _RX_CLK[0:1] clock fall time (80%–20%)	t <sub>TRXF</sub> <sup>2</sup>	0.7	—	2.4	ns

Notes:

1. The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state)</sub> for outputs. For example, t<sub>TRDVKH</sub> symbolizes TBI receive timing (TR) with respect to the time data input signals (D) reach the valid state (V) relative to the t<sub>TRX</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>TRDXKH</sub> symbolizes TBI receive timing (TR) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>TRX</sub> clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t<sub>TRX</sub> represents the TBI (T) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall). For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (TRX).</sub>

2. Guaranteed by design.

#### PCI/PCI-X

#### Table 54. PCI-X AC Timing Specifications at 133 MHz (continued)

Parameter	Symbol	Min	Max	Unit	Notes
HRESET to PCI-X initialization pattern hold time	t <sub>PCRHIX</sub>	0	50	ns	6, 12

Notes:

1. See the timing measurement conditions in the PCI-X 1.0a Specification.

- 2. Minimum times are measured at the package pin (not the test point). Maximum times are measured with the test point and load circuit.
- 3. Setup time for point-to-point signals applies to REQ and GNT only. All other signals are bused.
- 4. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 5. Setup time applies only when the device is not driving the pin. Devices cannot drive and receive signals at the same time.
- 6. Maximum value is also limited by delay to the first transaction (time for HRESET high to first configuration access, t<sub>PCRHFV</sub>). The PCI-X initialization pattern control signals after the rising edge of HRESET must be negated no later than two clocks before the first FRAME and must be floated no later than one clock before FRAME is asserted.
- 7. A PCI-X device is permitted to have the minimum values shown for t<sub>PCKHOV</sub> and t<sub>CYC</sub> only in PCI-X mode. In conventional mode, the device must meet the requirements specified in PCI 2.2 for the appropriate clock frequency.

8. Device must meet this specification independent of how many outputs switch simultaneously.

9. The timing parameter t<sub>PCIVKH</sub> is a minimum of 1.4 ns rather than the minimum of 1.2 ns in the PCI-X 1.0a Specification.

- 10. The timing parameter t<sub>PCRHFV</sub> is a minimum of 10 clocks rather than the minimum of 5 clocks in the *PCI-X 1.0a Specification.*
- 11. Guaranteed by characterization.

12. Guaranteed by design.

#### High-Speed Serial Interfaces (HSSI)

Figure 43 shows the SerDes reference clock connection reference circuits for HCSL type clock driver. It assumes that the DC levels of the clock driver chip is compatible with SerDes reference clock input's DC requirement.





Figure 44 shows the SerDes reference clock connection reference circuits for LVDS type clock driver. Since LVDS clock driver's common mode voltage is higher than the SerDes reference clock input's allowed range (100–400 mV), AC-coupled connection scheme must be used. It assumes the LVDS output driver features 50- $\Omega$  termination resistor. It also assumes that the LVDS transmitter establishes its own common mode level without relying on the receiver or other external component.



Figure 45 shows the SerDes reference clock connection reference circuits for LVPECL type clock driver. Since LVPECL driver's DC levels (both common mode voltages and output swing) are incompatible with the SerDes reference clock input's DC requirement, AC-coupling must be used. Figure 45 assumes that the LVPECL clock driver's output impedance is 50  $\Omega$ . R1 is used to DC-bias the LVPECL outputs prior

Table 56. Differential Transmitter	· (TX) Output	<b>Specifications</b>	(continued)
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Symbol	Parameter	Min	Nom	Max	Unit	Comments
V <sub>TX-DC-CM</sub>	The TX DC common mode voltage	0	_	3.6	V	The allowed DC common mode voltage under any conditions. See Note 6.
I <sub>TX-SHORT</sub>	TX short circuit current limit	_	_	90	mA	The total current the transmitter can provide when shorted to its ground
T <sub>TX-IDLE-MIN</sub>	Minimum time spent in electrical idle	50	_		UI	Minimum time a transmitter must be in electrical idle utilized by the receiver to start looking for an electrical idle exit after successfully receiving an electrical idle ordered set
T <sub>TX-IDLE-SET-TO-IDLE</sub>	Maximum time to transition to a valid electrical idle after sending an electrical idle ordered set			20	UI	After sending an electrical idle ordered set, the transmitter must meet all electrical idle specifications within this time. This is considered a debounce time for the transmitter to meet electrical idle after transitioning from L0.
T <sub>TX-IDLE-TO-DIFF-DATA</sub>	Maximum time to transition to valid TX specifications after leaving an electrical idle condition			20	UI	Maximum time to meet all TX specifications when transitioning from electrical idle to sending differential data. This is considered a debounce time for the TX to meet all TX specifications after leaving electrical idle
RL <sub>TX-DIFF</sub>	Differential return loss	12	_	—	dB	Measured over 50 MHz to 1.25 GHz. See Note 4.
RL <sub>TX-CM</sub>	Common mode return loss	6		—	dB	Measured over 50 MHz to 1.25 GHz. See Note 4.
Z <sub>TX-DIFF-DC</sub>	DC differential TX impedance	80	100	120	Ω	TX DC differential mode low impedance
Z <sub>TX-DC</sub>	Transmitter DC impedance	40	_	_	Ω	Required TX D+ as well as D– DC impedance during all states
L <sub>TX-SKEW</sub>	Lane-to-lane output skew	_	_	500 + 2 UI	ps	Static skew between any two transmitter lanes within a single Link
C <sub>TX</sub>	AC coupling capacitor	75	_	200	nF	All transmitters shall be AC coupled. The AC coupling is required either within the media or within the transmitting component itself. See note 8.

#### **PCI Express**



Figure 48. Minimum Transmitter Timing and Voltage Output Compliance Specifications

## 17.4.3 Differential Receiver (RX) Input Specifications

Table 57 defines the specifications for the differential input at all receivers (RXs). The parameters are specified at the component pins.

Symbol	Parameter	Min	Nom	Max	Unit	Comments
UI	Unit interval	399.88	400	400.12	ps	Each UI is 400 ps $\pm$ 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1.
V <sub>RX-DIFFp-p</sub>	Differential peak-to-peak input voltage	0.175	_	1.200	V	$V_{RX-DIFFp-p} = 2 \times  V_{RX-D+} - V_{RX-D-} $ . See Note 2.
T <sub>RX-EYE</sub>	Minimum receiver eye width	0.4	_	_	UI	The maximum interconnect media and transmitter jitter that can be tolerated by the receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 2 and 3.
T <sub>RX-EYE-MEDIAN-to-</sub> MAX-JITTER	Maximum time between the jitter median and maximum deviation from the median	_	_	0.3	UI	Jitter is defined as the measurement variation of the crossing points ( $V_{RX-DIFFp-p} = 0$ V) in relation to a recovered TX UI. A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI. See Notes 2, 3, and 7.

Table 57. Differential Receiver (RX) Input Specifications

Table 57. Differential Receiver (RX) Input Specifications (continued)

Symbol	Parameter	Min	Nom	Max	Unit	Comments
L <sub>TX-SKEW</sub>	Total Skew			20	ns	Skew across all lanes on a Link. This includes variation in the length of SKP ordered set (for example, COM and one to five symbols) at the RX as well as any delay differences arising from the interconnect itself.

#### Notes:

- 1. No test load is necessarily associated with this value.
- 2. Specified at the measurement point and measured over any 250 consecutive UIs. The test load in Figure 50 must be used as the RX device when taking measurements (also see the receiver compliance eye diagram shown in Figure 49). If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as a reference for the eye diagram.
- 3. A T<sub>RX-EYE</sub> = 0.40 UI provides for a total sum of 0.60 UI deterministic and random jitter budget for the transmitter and interconnect collected any 250 consecutive UIs. The T<sub>RX-EYE-MEDIAN-to-MAX-JITTER</sub> specification ensures a jitter distribution in which the median and the maximum deviation from the median is less than half of the total. UI jitter budget collected over any 250 consecutive TX UIs. Note that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value. If the clocks to the RX and TX are not derived from the same reference clock, the TX UI recovered from 3500 consecutive UI must be used as the reference for the eye diagram.
- 4. The receiver input impedance shall result in a differential return loss greater than or equal to 15 dB with the D+ line biased to 300 mV and the D– line biased to  $-{300 \text{ mV}}$  and a common mode return loss greater than or equal to 6 dB (no bias required) over a frequency range of 50 MHz to 1.25 GHz. This input impedance requirement applies to all valid input levels. The reference impedance for return loss measurements for is 50  $\Omega$  to ground for both the D+ and D– line (that is, as measured by a vector network analyzer with 50- $\Omega$  probes—see Figure 50). Note: that the series capacitors CTX is optional for the return loss measurement.
- 5. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.
- 6. The RX DC common mode Impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the RX ground.
- 7. It is recommended that the recovered TX UI is calculated using all edges in the 3500 consecutive UI interval with a fit algorithm using a minimization merit function. Least squares and median deviation fits have worked well with experimental and simulated data.

## 17.5 Receiver Compliance Eye Diagrams

The RX eye diagram in Figure 49 is specified using the passive compliance/test measurement load (see Figure 50) in place of any real PCI Express RX component.

Note: In general, the minimum receiver eye diagram measured with the compliance/test measurement load (see Figure 50) is larger than the minimum receiver eye diagram measured over a range of systems at the input receiver of any real PCI Express component. The degraded eye diagram at the input receiver is due to traces internal to the package as well as silicon parasitic characteristics which cause the real PCI Express component to vary in impedance from the compliance/test measurement load. The input receiver eye diagram is implementation specific and is not specified. RX component designer must provide additional margin to adequately compensate for the degraded minimum receiver eye diagram (shown in Figure 49) expected at the input receiver based on some adequate combination of system simulations and the return loss measured looking into the RX package and silicon. The RX eye diagram must be aligned in time using the jitter median to locate the center of the eye diagram.

#### Serial RapidIO

802.3ae-2002 is specified as the test pattern for use in eye pattern and jitter measurements. Annex 48B of IEEE Std. 802.3ae-2002 is recommended as a reference for additional information on jitter test methods.

## 18.9.1 Eye Template Measurements

For the purpose of eye template measurements, the effects of a single-pole high pass filter with a 3 dB point at (baud frequency)/1667 is applied to the jitter. The data pattern for template measurements is the continuous jitter test pattern (CJPAT) defined in Annex 48A of IEEE 802.3ae. All lanes of the LP-serial link shall be active in both the transmit and receive directions, and opposite ends of the links shall use asynchronous clocks. Four lane implementations shall use CJPAT as defined in Annex 48A. Single lane implementations shall use the CJPAT sequence specified in Annex 48A for transmission on lane 0. The amount of data represented in the eye shall be adequate to ensure that the bit error ratio is less than  $10^{-12}$ . The eye pattern shall be measured with AC coupling and the compliance template centered at 0 V differential. The left and right edges of the template shall be aligned with the mean zero crossing points of the measured data eye. The load for this test shall be  $100-\Omega$  resistive  $\pm 5\%$  differential to 2.5 GHz.

## 18.9.2 Jitter Test Measurements

For the purpose of jitter measurement, the effects of a single-pole high pass filter with a 3 dB point at (baud frequency)/1667 is applied to the jitter. The data pattern for jitter measurements is the Continuous Jitter test pattern (CJPAT) pattern defined in Annex 48A of IEEE 802.3ae. All lanes of the LP-serial link shall be active in both the transmit and receive directions, and opposite ends of the links shall use asynchronous clocks. Four lane implementations shall use CJPAT as defined in Annex 48A. Single lane implementations shall use the CJPAT sequence specified in Annex 48A for transmission on lane 0. Jitter shall be measured with AC coupling and at 0 V differential. Jitter measurement for the transmitter (or for calibration of a jitter tolerance setup) shall be performed with a test procedure resulting in a BER curve such as that described in Annex 48B of IEEE 802.3ae.

### 18.9.3 Transmit Jitter

Transmit jitter is measured at the driver output when terminated into a load of 100  $\Omega$  resistive ± 5% differential to 2.5 GHz.

### 18.9.4 Jitter Tolerance

Jitter tolerance is measured at the receiver using a jitter tolerance test signal. This signal is obtained by first producing the sum of deterministic and random jitter defined in Section 18.7, "Receiver Specifications," and then adjusting the signal amplitude until the data eye contacts the 6 points of the minimum eye opening of the receive template shown in Figure 54 and Table 69. Note that for this to occur, the test signal must have vertical waveform symmetry about the average value and have horizontal symmetry (including jitter) about the mean zero crossing. Eye template measurement requirements are as defined above. Random jitter is calibrated using a high pass filter with a low frequency corner at 20 MHz and a 20 dB/decade roll-off below this. The required sinusoidal jitter specified in Section 18.7, "Receiver Specifications," is then added to the signal and the test load is replaced by the receiver being tested.

**Package Description** 



- 1. All dimensions are in millimeters.
- 2. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 3. Maximum solder ball diameter measured parallel to datum A.
- 4. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
- 5. Capacitors may not be present on all devices.
- 6. Caution must be taken not to short capacitors or exposed metal capacitor pads on package top.
- 7. Parallelism measurement shall exclude any effect of mark on top surface of package.
- 8. All dimensions are symmetric across the package center lines unless dimensioned otherwise.

#### Figure 56. Mechanical Dimensions and Bottom Surface Nomenclature of the FC-PBGA with Stamped Lid

Table 72 provides the pin-out listing for the MPC8547E 783 FC-PBGA package.

#### NOTE

All note references in the following table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	PCI1 (One 64-Bit or One 32-Bit)		1	
PCI1_AD[63:32]	AB14, AC15, AA15, Y16, W16, AB16, AC16, AA16, AE17, AA18, W18, AC17, AD16, AE16, Y17, AC18, AB18, AA19, AB19, AB21, AA20, AC20, AB20, AB22, AC22, AD21, AB23, AF23, AD23, AE23, AC23, AC24	I/O	OV <sub>DD</sub>	17
PCI1_AD[31:0]	AH6, AE7, AF7, AG7, AH7, AF8, AH8, AE9, AH9, AC10, AB10, AD10, AG10, AA10, AH10, AA11, AB12, AE12, AG12, AH12, AB13, AA12, AC13, AE13, Y14, W13, AG13, V14, AH13, AC14, Y15, AB15	I/O	OV <sub>DD</sub>	17
PCI1_C_BE[7:4]	AF15, AD14, AE15, AD15	I/O	OV <sub>DD</sub>	17
PCI1_C_BE[3:0]	AF9, AD11, Y12, Y13	I/O	OV <sub>DD</sub>	17
PCI1_PAR64	W15	I/O	OV <sub>DD</sub>	—
PCI1_GNT[4:1]	AG6, AE6, AF5, AH5	0	OV <sub>DD</sub>	5, 9, 35
PCI1_GNT0	AG5	I/O	OV <sub>DD</sub>	—
PCI1_IRDY	AF11	I/O	OV <sub>DD</sub>	2
PCI1_PAR	AD12	I/O	OV <sub>DD</sub>	—
PCI1_PERR	AC12	I/O	OV <sub>DD</sub>	2
PCI1_SERR	V13	I/O	OV <sub>DD</sub>	2, 4
PCI1_STOP	W12	I/O	OV <sub>DD</sub>	2
PCI1_TRDY	AG11	I/O	OV <sub>DD</sub>	2
PCI1_REQ[4:1]	AH2, AG4, AG3, AH4	ļ	OV <sub>DD</sub>	—
PCI1_REQ0	AH3	I/O	OV <sub>DD</sub>	—
PCI1_CLK	AH26	I	OV <sub>DD</sub>	39
PCI1_DEVSEL	AH11	I/O	OV <sub>DD</sub>	2
PCI1_FRAME	AE11	I/O	OV <sub>DD</sub>	2
PCI1_IDSEL	AG9	I	OV <sub>DD</sub>	—
PCI1_REQ64	AF14	I/O	OV <sub>DD</sub>	2, 5,10
PCI1_ACK64	V15	I/O	OV <sub>DD</sub>	2
Reserved	AE28	—	—	2
Reserved	AD26	—	—	2
Reserved	AD25		—	2

#### Table 72. MPC8547E Pinout Listing

Table 72	. MPC8547E	<b>Pinout</b>	Listing (	(continued)
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Signal Package Pin Number		Pin Type	Power Supply	Notes
	Local Bus Controller Interface		I	
LAD[0:31]	E27, B20, H19, F25, A20, C19, E28, J23, A25, K22, B28, D27, D19, J22, K20, D28, D25, B25, E22, F22, F21, C25, C22, B23, F20, A23, A22, E19, A21, D21, F19, B21	I/O	BV <sub>DD</sub>	_
LDP[0:3]	K21, C28, B26, B22	I/O	BV <sub>DD</sub>	—
LA[27]	H21	0	BV <sub>DD</sub>	5, 9
LA[28:31]	H20, A27, D26, A28	0	BV <sub>DD</sub>	5, 7, 9
LCS[0:4]	J25, C20, J24, G26, A26	0	BV <sub>DD</sub>	—
LCS5/DMA_DREQ2	D23	I/O	BV <sub>DD</sub>	1
LCS6/DMA_DACK2	G20	0	BV <sub>DD</sub>	1
LCS7/DMA_DDONE2	E21	0	BV <sub>DD</sub>	1
LWE0/LBS0/LSDDQM[0]	G25	0	BV <sub>DD</sub>	5, 9
LWE1/LBS1/LSDDQM[1]	C23	0	BV <sub>DD</sub>	5, 9
LWE2/LBS2/LSDDQM[2]	J21	0	BV <sub>DD</sub>	5, 9
LWE3/LBS3/LSDDQM[3]	A24	0	BV <sub>DD</sub>	5, 9
LALE	H24	0	BV <sub>DD</sub>	5, 8, 9
LBCTL	G27	0	BV <sub>DD</sub>	5, 8, 9
LGPL0/LSDA10	F23	0	BV <sub>DD</sub>	5, 9
LGPL1/LSDWE	G22	0	BV <sub>DD</sub>	5, 9
LGPL2/LOE/LSDRAS	B27	0	BV <sub>DD</sub>	5, 8, 9
LGPL3/LSDCAS	F24	0	BV <sub>DD</sub>	5, 9
LGPL4/LGTA/LUPWAIT/LPBSE	H23	I/O	BV <sub>DD</sub>	—
LGPL5	E26	0	BV <sub>DD</sub>	5, 9
LCKE	E24	0	BV <sub>DD</sub>	—
LCLK[0:2]	E23, D24, H22	0	BV <sub>DD</sub>	—
LSYNC_IN	F27	I	BV <sub>DD</sub>	—
LSYNC_OUT	F28	0	BV <sub>DD</sub>	_
	DMA		l	1
DMA_DACK[0:1]	AD3, AE1	0	OV <sub>DD</sub>	5, 9, 107
DMA_DREQ[0:1]	AD4, AE2	I	OV <sub>DD</sub>	—
DMA_DDONE[0:1]	AD2, AD1	0	OV <sub>DD</sub>	
	Programmable Interrupt Controller			
UDE	AH16	I	OV <sub>DD</sub>	_
MCP	AG19	I	OV <sub>DD</sub>	—

#### Table 73. MPC8545E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PCI1_FRAME	AE11	I/O	OV <sub>DD</sub>	2
PCI1_IDSEL	AG9	I	OV <sub>DD</sub>	_
PCI1_REQ64/PCI2_FRAME	AF14	I/O	OV <sub>DD</sub>	2, 5, 10
PCI1_ACK64/PCI2_DEVSEL	V15	I/O	OV <sub>DD</sub>	2
PCI2_CLK	AE28	I	OV <sub>DD</sub>	39
PCI2_IRDY	AD26	I/O	OV <sub>DD</sub>	2
PCI2_PERR	AD25	I/O	OV <sub>DD</sub>	2
PCI2_GNT[4:1]	AE26, AG24, AF25, AE25	0	OV <sub>DD</sub>	5, 9, 35
PCI2_GNT0	AG25	I/O	OV <sub>DD</sub>	_
PCI2_SERR	AD24	I/O	OV <sub>DD</sub>	2,4
PCI2_STOP	AF24	I/O	OV <sub>DD</sub>	2
PCI2_TRDY	AD27	I/O	OV <sub>DD</sub>	2
PCI2_REQ[4:1]	AD28, AE27, W17, AF26	I	OV <sub>DD</sub>	_
PCI2_REQ0	AH25	I/O	OV <sub>DD</sub>	_
	DDR SDRAM Memory Interface			
MDQ[0:63]	L18, J18, K14, L13, L19, M18, L15, L14, A17, B17, A13, B12, C18, B18, B13, A12, H18, F18, J14, F15, K19, J19, H16, K15, D17, G16, K13, D14, D18, F17, F14, E14, A7, A6, D5, A4, C8, D7, B5, B4, A2, B1, D1, E4, A3, B2, D2, E3, F3, G4, J5, K5, F6, G5, J6, K4, J1, K2, M5, M3, J3, J2, L1, M6	I/O	GV <sub>DD</sub>	
MECC[0:7]	H13, F13, F11, C11, J13, G13, D12, M12	I/O	GV <sub>DD</sub>	—
MDM[0:8]	M17, C16, K17, E16, B6, C4, H4, K1, E13	0	GV <sub>DD</sub>	_
MDQS[0:8]	M15, A16, G17, G14, A5, D3, H1, L2, C13	I/O	GV <sub>DD</sub>	_
MDQS[0:8]	L17, B16, J16, H14, C6, C2, H3, L4, D13	I/O	GV <sub>DD</sub>	_
MA[0:15]	A8, F9, D9, B9, A9, L10, M10, H10, K10, G10, B8, E10, B10, G6, A10, L11	Ο	GV <sub>DD</sub>	—
MBA[0:2]	F7, J7, M11	0	GV <sub>DD</sub>	_
MWE	E7	0	GV <sub>DD</sub>	_
MCAS	H7	0	GV <sub>DD</sub>	_
MRAS	L8	0	GV <sub>DD</sub>	_
MCKE[0:3]	F10, C10, J11, H11	0	GV <sub>DD</sub>	11
MCS[0:3]	K8, J8, G8, F8	0	GV <sub>DD</sub>	_
MCK[0:5]	H9, B15, G2, M9, A14, F1	0	GV <sub>DD</sub>	_
MCK[0:5]	J9, A15, G1, L9, B14, F2	0	GV <sub>DD</sub>	
MODT[0:3]	E6, K6, L7, M7	0	GV <sub>DD</sub>	—

Signal	Package Pin Number	Pin Type	Power Supply	Notes
GV <sub>DD</sub>	B3, B11, C7, C9, C14, C17, D4, D6, D10, D15, E2, E8, E11, E18, F5, F12, F16, G3, G7, G9, G11, H5, H12, H15, H17, J10, K3, K12, K16, K18, L6, M4, M8, M13	Power for DDR1 and DDR2 DRAM I/O voltage (1.8 V, 2.5 V)	GV <sub>DD</sub>	
BV <sub>DD</sub>	C21, C24, C27, E20, E25, G19, G23, H26, J20	Power for local bus (1.8 V, 2.5 V, 3.3 V)	BV <sub>DD</sub>	_
V <sub>DD</sub>	M19, N12, N14, N16, N18, P11, P13, P15, P17, P19, R12, R14, R16, R18, T11, T13, T15, T17, T19, U12, U14, U16, U18, V17, V19	Power for core (1.1 V)	V <sub>DD</sub>	_
SV <sub>DD</sub>	L25, L27, M24, N28, P24, P26, R24, R27, T25, V24, V26, W24, W27, Y25, AA28, AC27	Core power for SerDes transceivers (1.1 V)	SV <sub>DD</sub>	_
XV <sub>DD</sub>	L20, L22, N23, P21, R22, T20, U23, V21, W22, Y20	Pad power for SerDes transceivers (1.1 V)	XV <sub>DD</sub>	_
AVDD_LBIU	J28	Power for local bus PLL (1.1 V)	_	26
AVDD_PCI1	AH21	Power for PCI1 PLL (1.1 V)	_	26
AVDD_PCI2	AH22	Power for PCI2 PLL (1.1 V)		26
AVDD_CORE	AH15	Power for e500 PLL (1.1 V)		26
AVDD_PLAT	AH19	Power for CCB PLL (1.1 V)		26
AVDD_SRDS	U25	Power for SRDSPLL (1.1 V)		26
SENSEVDD	M14	0	V <sub>DD</sub>	13
SENSEVSS	M16	—	—	13
	Analog Signals			
MVREF	A18	I Reference voltage signal for DDR	MVREF	

#### Table 73. MPC8545E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PCI1_TRDY	AG11	I/O	OV <sub>DD</sub>	2
PCI1_REQ[4:1]	AH2, AG4, AG3, AH4	ļ	OV <sub>DD</sub>	—
PCI1_REQ0	AH3	I/O	OV <sub>DD</sub>	—
PCI1_CLK	AH26	I	OV <sub>DD</sub>	39
PCI1_DEVSEL	AH11	I/O	OV <sub>DD</sub>	2
PCI1_FRAME	AE11	I/O	OV <sub>DD</sub>	2
PCI1_IDSEL	AG9	I	OV <sub>DD</sub>	—
cfg_pci1_width	AF14	I/O	OV <sub>DD</sub>	112
Reserved	V15	_	_	110
Reserved	AE28	_	_	2
Reserved	AD26	_	_	110
Reserved	AD25	_	_	110
Reserved	AE26	_	_	110
cfg_pci1_clk	AG24	I	OV <sub>DD</sub>	5
Reserved	AF25	_	_	101
Reserved	AE25	_	_	110
Reserved	AG25	_	_	110
Reserved	AD24	_	_	110
Reserved	AF24	_	_	110
Reserved	AD27	_	_	110
Reserved	AD28, AE27, W17, AF26	_	_	110
Reserved	AH25	_	_	110
	DDR SDRAM Memory Interface			
MDQ[0:63]	L18, J18, K14, L13, L19, M18, L15, L14, A17, B17, A13, B12, C18, B18, B13, A12, H18, F18, J14, F15, K19, J19, H16, K15, D17, G16, K13, D14, D18, F17, F14, E14, A7, A6, D5, A4, C8, D7, B5, B4, A2, B1, D1, E4, A3, B2, D2, E3, F3, G4, J5, K5, F6, G5, J6, K4, J1, K2, M5, M3, J3, J2, L1, M6	I/O	GV <sub>DD</sub>	_
MECC[0:7]	H13, F13, F11, C11, J13, G13, D12, M12	I/O	GV <sub>DD</sub>	—
MDM[0:8]	M17, C16, K17, E16, B6, C4, H4, K1, E13	0	GV <sub>DD</sub>	
MDQS[0:8]	M15, A16, G17, G14, A5, D3, H1, L2, C13	I/O	GV <sub>DD</sub>	_
MDQS[0:8]	L17, B16, J16, H14, C6, C2, H3, L4, D13	I/O	GV <sub>DD</sub>	
MA[0:15]	A8, F9, D9, B9, A9, L10, M10, H10, K10, G10, B8, E10, B10, G6, A10, L11	0	GV <sub>DD</sub>	—
MBA[0:2]	F7, J7, M11	0	GV <sub>DD</sub>	_

#### Table 74. MPC8543E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes		
LSYNC_IN	F27	I	BV <sub>DD</sub>	—		
LSYNC_OUT	F28	0	BV <sub>DD</sub>	—		
DMA						
DMA_DACK[0:1]	AD3, AE1	0	OV <sub>DD</sub>	5, 9, 108		
DMA_DREQ[0:1]	AD4, AE2	I	OV <sub>DD</sub>	—		
DMA_DDONE[0:1]	AD2, AD1	0	OV <sub>DD</sub>	—		
Programmable Interrupt Controller						
UDE	AH16	I	OV <sub>DD</sub>	_		
MCP	AG19	I	OV <sub>DD</sub>	—		
IRQ[0:7]	AG23, AF18, AE18, AF20, AG18, AF17, AH24, AE20	I	OV <sub>DD</sub>	—		
IRQ[8]	AF19	I	OV <sub>DD</sub>	—		
IRQ[9]/DMA_DREQ3	AF21	I	OV <sub>DD</sub>	1		
IRQ[10]/DMA_DACK3	AE19	I/O	OV <sub>DD</sub>	1		
IRQ[11]/DMA_DDONE3	AD20	I/O	OV <sub>DD</sub>	1		
IRQ_OUT	AD18	0	OV <sub>DD</sub>	2, 4		
Ethernet Management Interface						
EC_MDC	AB9	0	OV <sub>DD</sub>	5, 9		
EC_MDIO	AC8	I/O	OV <sub>DD</sub>	—		
Gigabit Reference Clock						
EC_GTX_CLK125	V11	I	LV <sub>DD</sub>	—		
Three-Speed Ethernet Controller (Gigabit Ethernet 1)						
TSEC1_RXD[7:0]	R5, U1, R3, U2, V3, V1, T3, T2	I	LV <sub>DD</sub>	—		
TSEC1_TXD[7:0]	T10, V7, U10, U5, U4, V6, T5, T8	0	LV <sub>DD</sub>	5, 9		
TSEC1_COL	R4	I	LV <sub>DD</sub>	—		
TSEC1_CRS	V5	I/O	LV <sub>DD</sub>	20		
TSEC1_GTX_CLK	U7	0	LV <sub>DD</sub>	—		
TSEC1_RX_CLK	U3	I	LV <sub>DD</sub>	—		
TSEC1_RX_DV	V2	I	LV <sub>DD</sub>	—		
TSEC1_RX_ER	T1	I	LV <sub>DD</sub>	—		
TSEC1_TX_CLK	Т6	I	LV <sub>DD</sub>	—		
TSEC1_TX_EN	U9	0	LV <sub>DD</sub>	30		
TSEC1_TX_ER	Τ7	0	LV <sub>DD</sub>			
GPIN[0:7]	P2, R2, N1, N2, P3, M2, M1, N3	I	LV <sub>DD</sub>	103		

Signal	Package Pin Number	Pin Type	Power Supply	Notes			
SENSEVSS	M16	—	—	13			
Analog Signals							
MVREF	A18	l Reference voltage signal for DDR	MVREF				
SD_IMP_CAL_RX	L28	I	200 Ω (±1%) to GND	_			
SD_IMP_CAL_TX	AB26	I	100 Ω (±1%) to GND	—			
SD_PLL_TPA	U26	0	AVDD_SRDS	24			

#### Table 74. MPC8543E Pinout Listing (continued)

**Note:** All note references in this table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.